Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	Applicant(s)/Patent under Reexamination	
10/768,650	NAKANISHI ET AL.		
Examiner	Art Unit		
BINH Q. TRAN	3748		

SEARCHED					
Class	Subclass	Date	Examiner		
60	274	05/24/05	RST		
	275				
	286				
	297				
	301				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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INVENTOR SEARCHED	10/05/65	BO		
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